Application/Control No. Applicant(s)/Patent Under Reexamination 09/665,899 IWASE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Julian A. Mercado 1745 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 11-1998 US-5,840,438 Johnson et al. 429/30 Α US-6,365,295 B1 04-2002 429/34 В Matsukawa et al. С US-US-D US-Ε F US-US-Н ı US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Name Classification Country Country Code-Number-Kind Code MM-YYYY 5-251097 09-1993 Japan Sugiyama H01M 8/02 Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.